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(54) Title: REFLECTIVE AND INTERFERENCE CONTROLLED ABSORPTIVE CONTACTOR

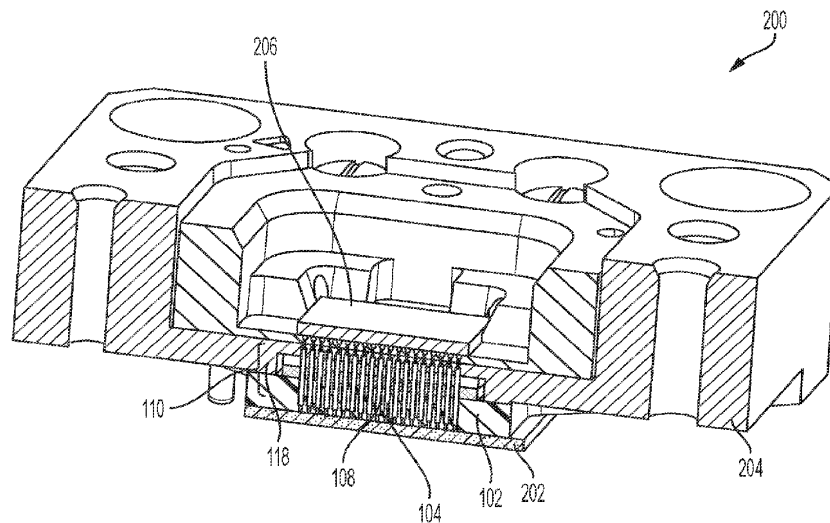


Fig. 2D

(57) Abstract: An apparatus (100) including a contactor (102) having a hole (106) and including a radio frequency absorptive material (108) and a probe (104) inserted in the hole (106) to couple a test signal to a device under test, such as an integrated circuit (206), is disclosed. A test system for testing integrated circuits (206) including a contactor (102) including a radio frequency absorptive material (108) is disclosed. A method for making the contactor (102) is also disclosed, where the radio frequency absorptive material (108) is formed by 3D printing, moulding, coating or micro-machining.

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